



SHEET 1 OF 3

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
043888-0267SERIAL NO.
10/629,815

APPLICANT

Tsutomu OHZUKU, et al.FILING DATE
July 30, 2003GROUP
1745

U.S. PATENT DOCUMENTS

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EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Codes-Number &-Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)						
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(Substitute for form 1449/PTO)

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